L Number	Hits	Search Text	DB	Time stamp
51	1402	(microphone near3 (membrane flex\$4 diaphragm))	USPAT;	2004/08/20 02:17
			US-PGPUB;	
			EPO; JPO	
52	20	((microphone near3 (membrane flex\$4 diaphragm))) and ((generat\$4	USPAT;	2004/08/20 02:02
		produc\$4) near6 (wind and (sound noise vibrat\$4)))	US-PGPUB;	
			EPO; JPO	
53	6	(((microphone near3 (membrane flex\$4 diaphragm))) and ((generat\$4	USPAT;	2004/08/20 02:06
		produc\$4) near6 (wind and (sound noise vibrat\$4)))) and (acoustic near3	US-PGPUB;	
		signal)	EPO; JPO	
54	23	"hotwire anemometer"	USPAT;	2004/08/20 02:07
			US-PGPUB;	
	_		EPO; JPO	
55	0	"hotwire anemometer" and (microphone near3 (membrane flex\$4	USPAT;	2004/08/20 02:07
		diaphragm))	US-PGPUB;	
	_		EPO; JPO	
56	6	"hotwire anemometer" and microphone	USPAT;	2004/08/20 02:07
			US-PGPUB;	
			EPO; JPO	
57	4255	microelectromechanical	USPAT;	2004/08/20 02:18
			US-PGPUB;	
	000		EPO; JPO	
58	800	microelectromechanical.clm.	USPAT;	2004/08/20 02:18
			US-PGPUB;	
	216		EPO; JPO	
60	316	microelectromechanical.clm. and ((plurality multipl\$4 second pair two)	USPAT;	2004/08/20 02:19
		near3 (material sample substrate)).clm.	US-PGPUB;	
	<b>50</b>		EPO; JPO	
	52	(microelectromechanical.clm. and ((plurality multipl\$4 second pair two)	USPAT;	2004/08/20 02:21
		near3 (material sample substrate)).clm.) and ((remov\$3 strip\$4) near3	US-PGPUB;	
	12	(material substrate sample)).clm.	EPO; JPO	
61	13	((microelectromechanical.clm. and ((plurality multipl\$4 second pair two)	USPAT;	2004/08/20 02:23
i.		near3 (material sample substrate)).clm.) and ((remov\$3 strip\$4) near3	US-PGPUB;	
		(material substrate sample)).clm.) and ((leg arm (extending near2 member	EPO; JPO	
		element) extension) and gap)		